IDS Form PTO/SB/08: Substitute for form 1449A/PTO	C	omplete if Know	OIPE
	Application Number	10/757,415	/8
INFORMATION DISCLOSURE	Filing Date	January 15, 2004	NOV 1 0 2005 W
	First Named Inventor	Hisashi KANEKO	3 (00)
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)	Examiner Name	Not yet assigned	& Manual Co
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Examiner Initials No.1		Document Number Number-Kind Code ² (if known)	Issue or Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear			
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Note: Submission of copies of U.S. Patents and published U.S. Patent Applications is not required.

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AS		JP Pub. No. 10-050785	02/20/1998			Abstract and partial translation			
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	NON PATENT LITERATURE DOCUMENTS					
Examiner Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	Translation ⁶			
AS		Notice of Reasons for Rejection mailed September 6, 2005, issued by the Japanese Patent Office in counterpart Japanese Application No. 2003-344526 and English translation thereof	Yes			
AS		HITOSHI OHMURA, A talk about design of experiment and analysis of variance, Japan Science and Technology Federation, 1984, p. 1-10 and English translation thereof	Yes			
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Signature	/Ayal Sharon/	Considered	12/01/2000



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Form PTO 14	149	Patent and Trademark Office -	U.S. Department of Commerce		

INFORMATION DISCLOSURE CITATION

Atty. Docket No.	04173.0441	Application No.	10 /757, 415
Applicant	Hisashi KANEKO, et al.		
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